



# Samples for helium plasma studies on AUG and JET

**M. Rasiński, et al.**



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## Samples for helium plasma studies on **JET**

M. Rasinski, S. Brezinsek, A. Kreter, S. Möller, M. Gago, I. Jecu, Y. Zayachuk,  
G.F. Matthews, B. Thomas, S. Silburn, A. Widdowson, C. Porosnicu



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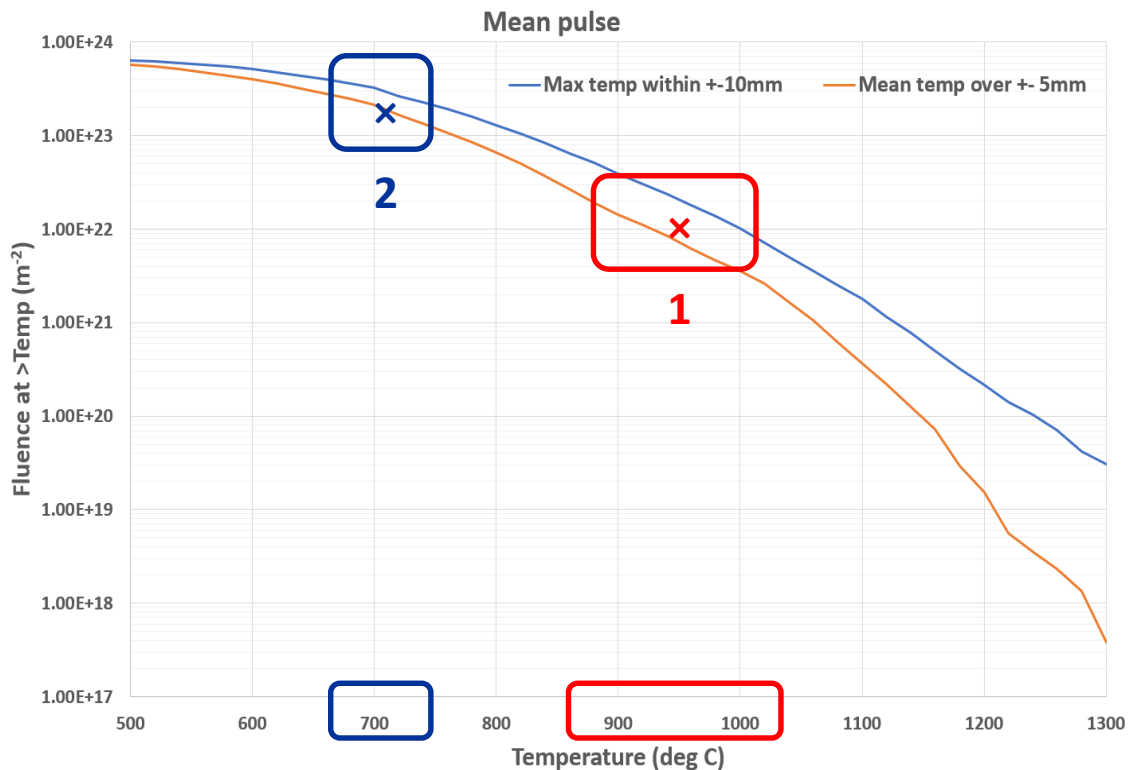


## Samples for helium plasma studies on AUG

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# Exposure aims



For 1000 pulses

1<sup>st</sup> scenario – Fuzz formation  
Temperature ~900-1000 °C  
Fluence ~ 1.5E25  $\text{m}^{-2}$

For 1000 pulses

2<sup>nd</sup> scenario – He campaign  
conditions  
Temperature - 700 °C  
Fluence ~ 2E26  $\text{m}^{-2}$

Plot based on probe 26 data in Tile 6 of the fluence per pulse against time spent above a certain temperature as determined by IR.  
The plotted are for the average pulse

# Experimental set-up



Samples: W-CFC, bulk W JET lamella and W-polished-ITER grade(FZJ), Bias: -100V ~ 80 eV

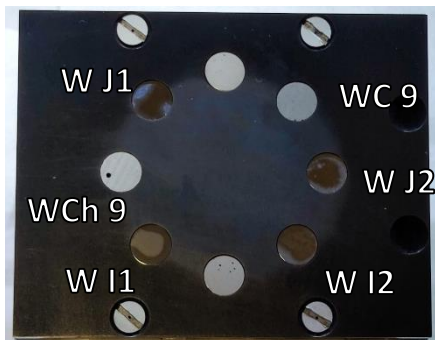
## 1<sup>st</sup> exposure – Fuzz formation

Temperature ~ 950 °C

Ion Flux ~  $4.5 \times 10^{22} \text{ m}^{-2}\text{s}^{-1}$

Fluence ~  $1.5 \times 10^{25} \text{ m}^{-2}$

BEFORE

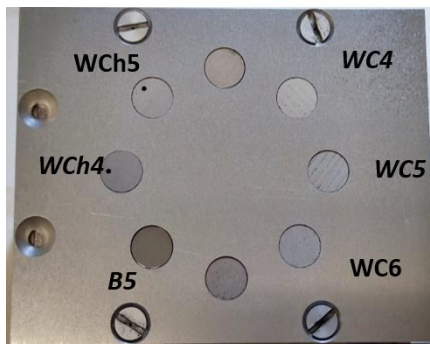


## 2<sup>nd</sup> exposure – He campaign

Temperature ~ 700 °C

Ion Flux ~  $1.1\text{-}1.2 \times 10^{22} \text{ m}^{-2}\text{s}^{-1}$

Fluence ~  $2 \times 10^{26} \text{ m}^{-2}$

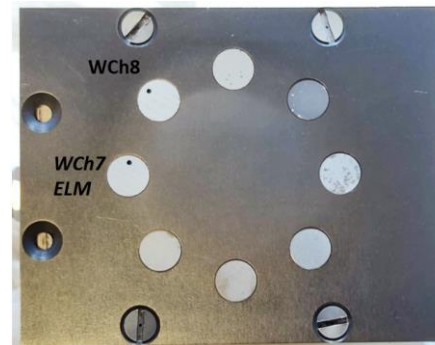


## 3<sup>rd</sup> exposure: ELM-like heat pulse

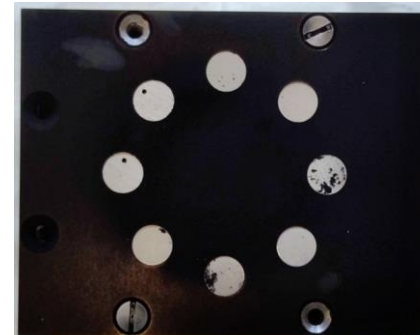
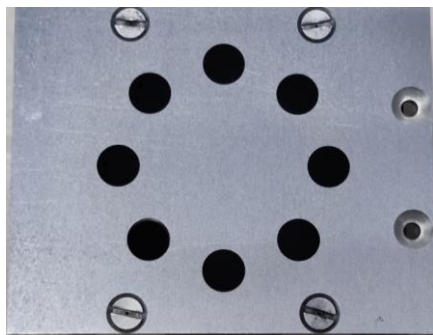
Temperature ~ 730 °C

Ion Flux ~  $1.1\text{-}1.2 \times 10^{22} \text{ m}^{-2}\text{s}^{-1}$

Fluence ~  $2 \times 10^{26} \text{ m}^{-2}$



AFTER



# Samples for helium plasma studies on JET



## 1<sup>st</sup> exposure – Fuzz formation

Temperature  $\sim 950$  °C

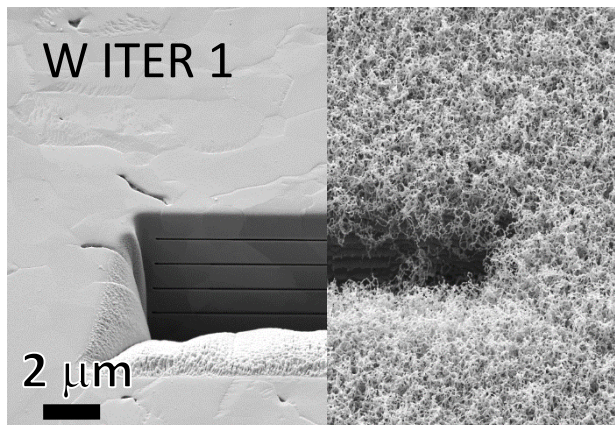
Ion Flux  $\sim 4.5 \times 10^{22} \text{ m}^{-2}\text{s}^{-1}$

Fluence  $\sim 1.5 \times 10^{25} \text{ m}^{-2}$

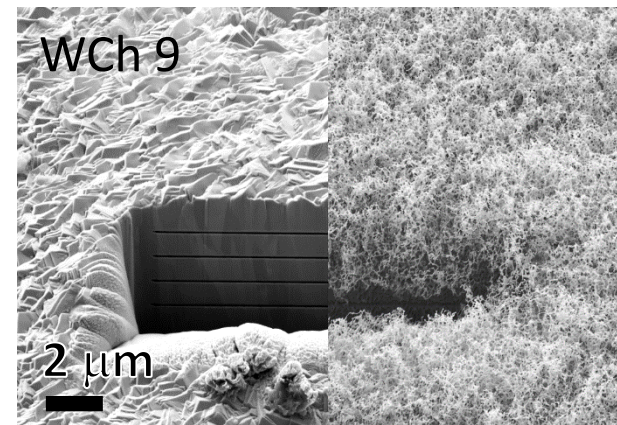
Energy  $\sim 80$  eV



W bulk JET lamella



W bulk ITER grade (FZJ)



W coating on CFC

All three types of materials show similar fuzz formation



# Samples for helium plasma studies on JET



## 1<sup>st</sup> exposure – Fuzz formation

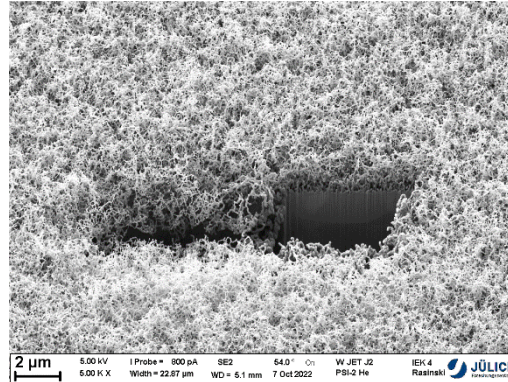
Temperature  $\sim 950\text{ }^{\circ}\text{C}$

Ion Flux  $\sim 4.5 \times 10^{22}\text{ m}^{-2}\text{s}^{-1}$

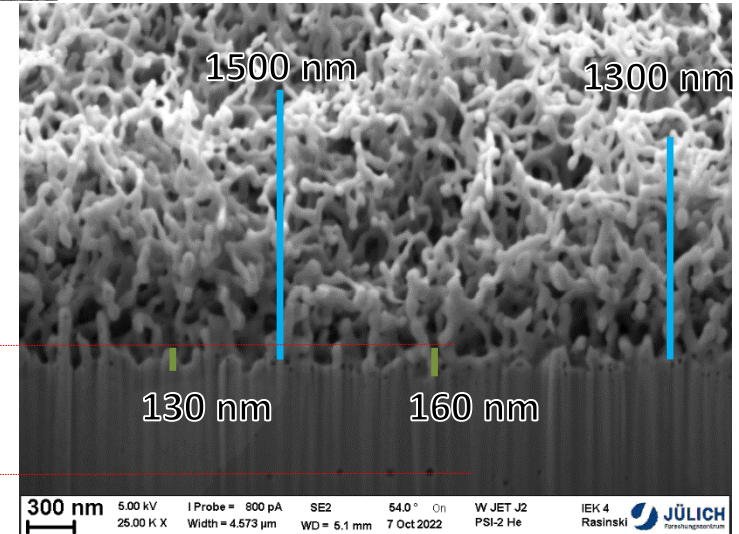
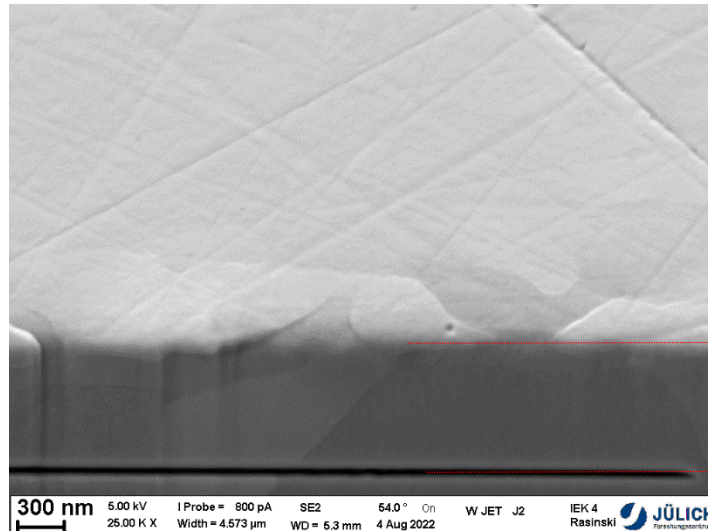
Fluence  $\sim 1.5 \times 10^{25}\text{ m}^{-2}$

Energy  $\sim 80\text{ eV}$

W JET 2



**Fuzz – 1300 – 1500 nm**



# Samples for helium plasma studies on JET



## 1<sup>st</sup> exposure – Fuzz formation

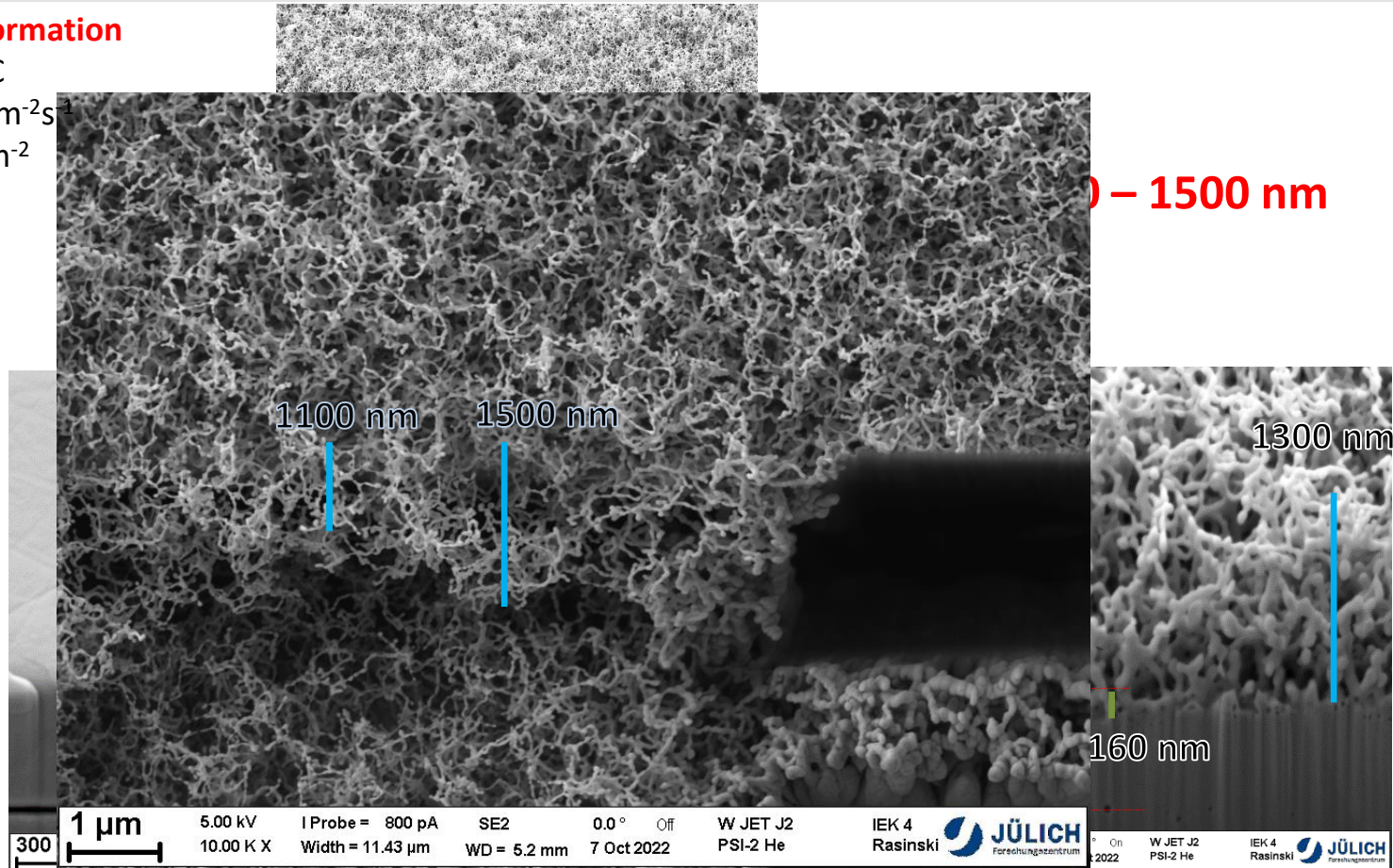
Temperature  $\sim 950\text{ }^\circ\text{C}$

Ion Flux  $\sim 4.5 \times 10^{22}\text{ m}^{-2}\text{s}^{-1}$

Fluence  $\sim 1.5 \times 10^{25}\text{ m}^{-2}$

Energy  $\sim 80\text{ eV}$

W JET 2





# Samples for helium plasma studies on JET



## 1<sup>st</sup> exposure – Fuzz formation

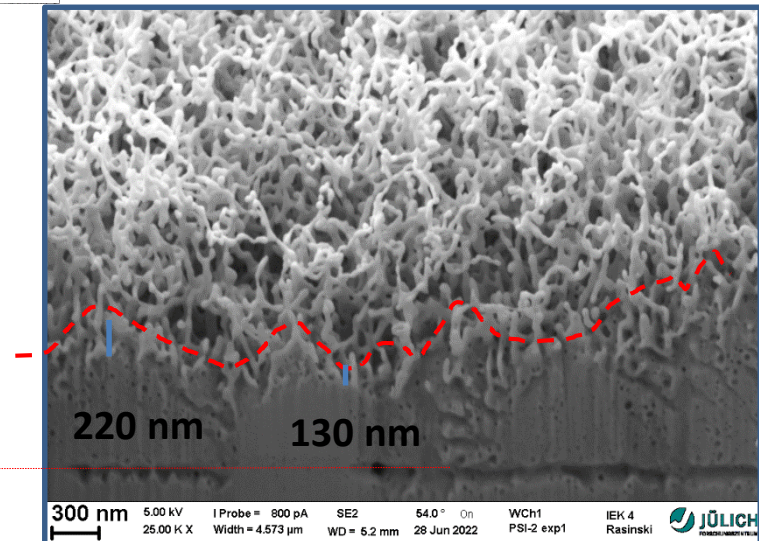
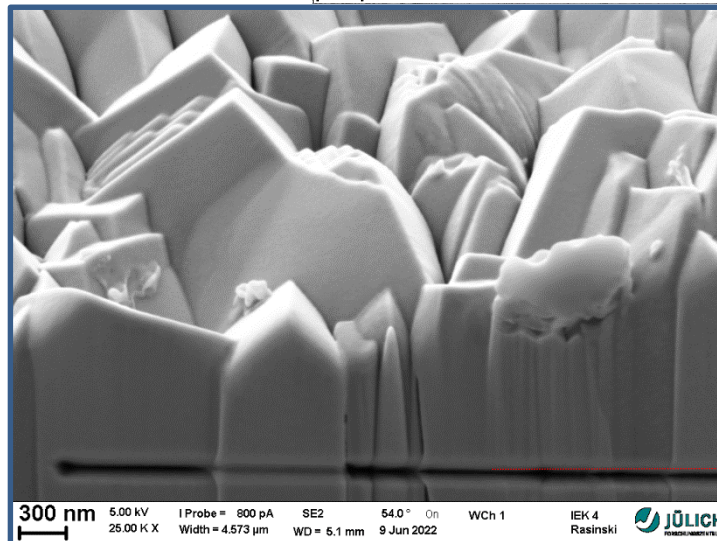
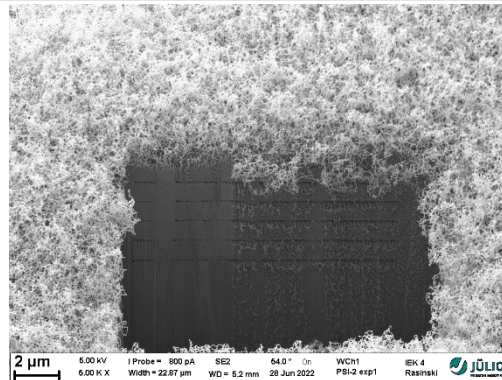
Temperature  $\sim 950\text{ }^{\circ}\text{C}$

Ion Flux  $\sim 4.5 \times 10^{22}\text{ m}^{-2}\text{s}^{-1}$

Fluence  $\sim 1.5 \times 10^{25}\text{ m}^{-2}$

Energy  $\sim 80\text{ eV}$

W Ch 1



# Samples for helium plasma studies on JET



## 1<sup>st</sup> exposure – Fuzz formation

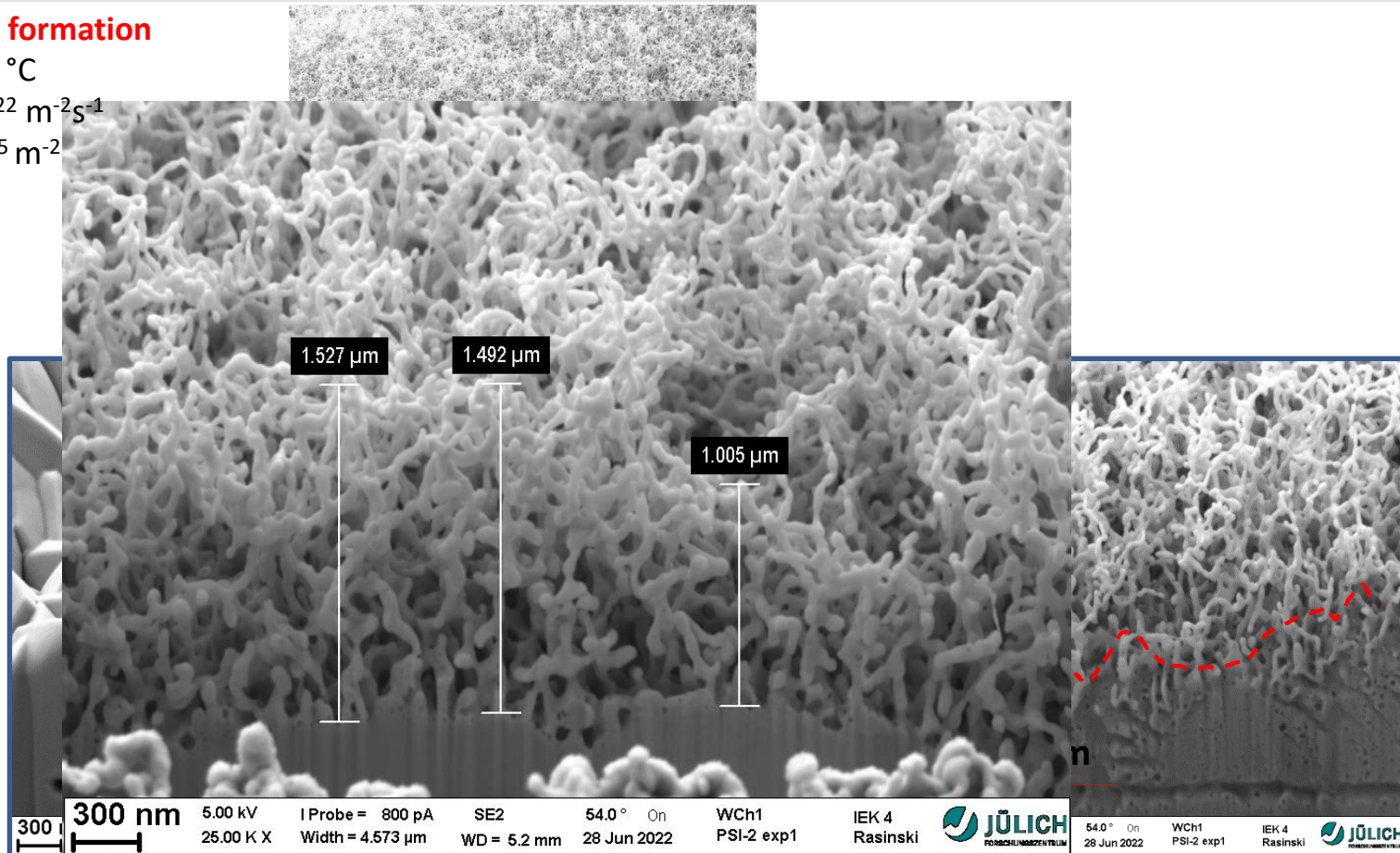
Temperature  $\sim 950\text{ }^\circ\text{C}$

Ion Flux  $\sim 4.5 \times 10^{22}\text{ m}^{-2}\text{s}^{-1}$

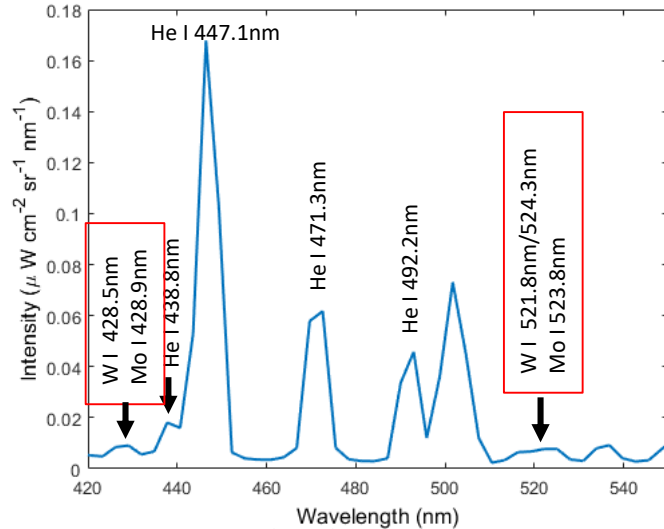
Fluence  $\sim 1.5 \times 10^{25}\text{ m}^{-2}$

Energy  $\sim 80\text{ eV}$

W Ch 1



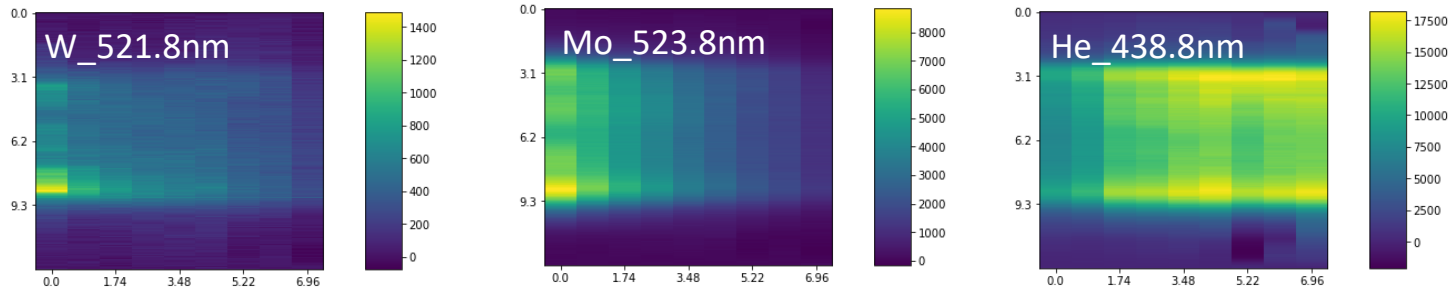
# Spectroscopy



*Spectrum during W fuzz formation experiment*

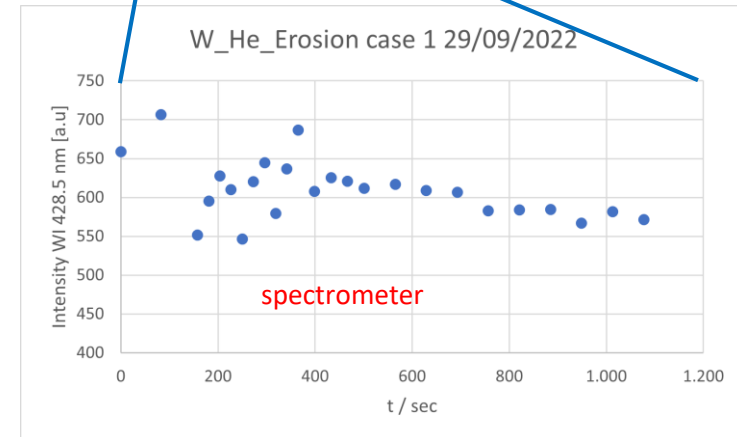
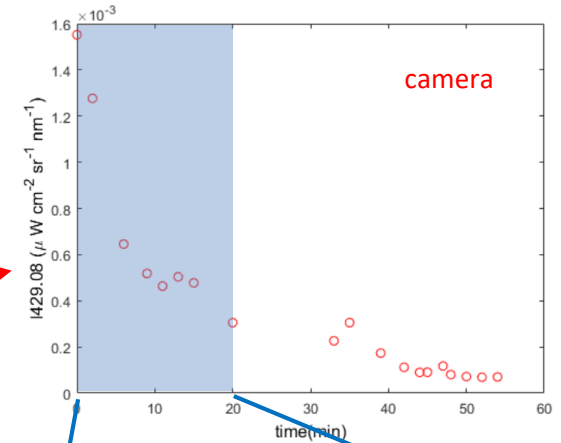
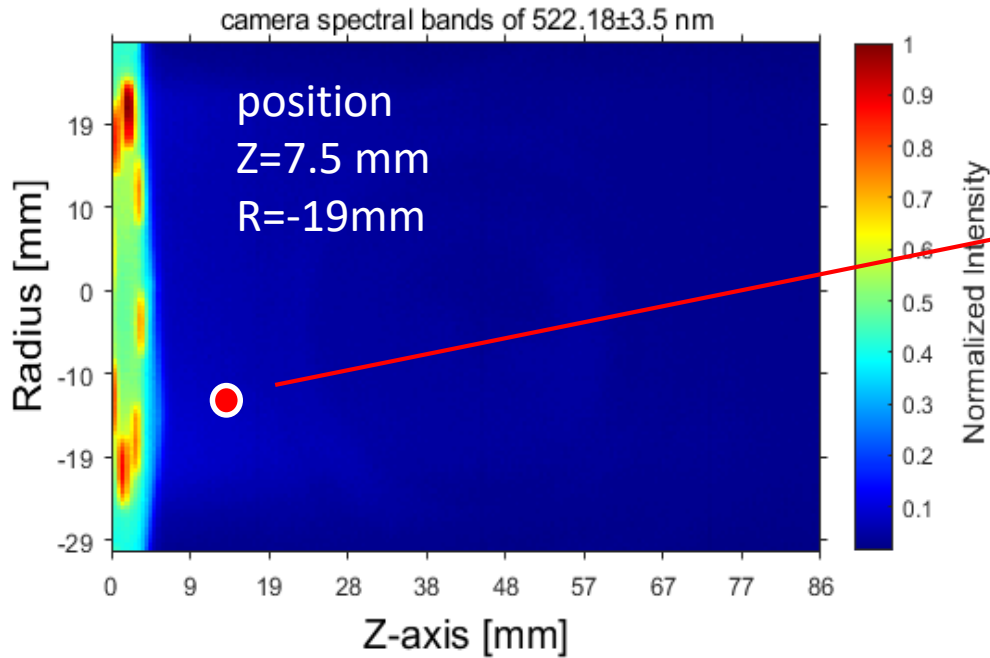
Wavelength range (nm): 400-1000  
Spectral resolution (FWHM, nm): 7  
Spectral bands: 204  
Spatial resolution in this set up (mm/pixel): ~0.48

## Separation of W and Mo from He plasma



*Spatial distribution during W fuzz formation*

# Spectroscopy - evolution of time



The results of both hyperspectral camera and spectrometer show the downward trend of W I intensity.



# Samples for helium plasma studies on JET



## 1<sup>st</sup> exposure – Fuzz formation

Temperature  $\sim 950$  °C  
Ion Flux  $\sim 4.5 \times 10^{22}$  m<sup>-2</sup>s<sup>-1</sup>  
Fluence  $\sim 1.5 \times 10^{25}$  m<sup>-2</sup>  
Energy  $\sim 80$  eV

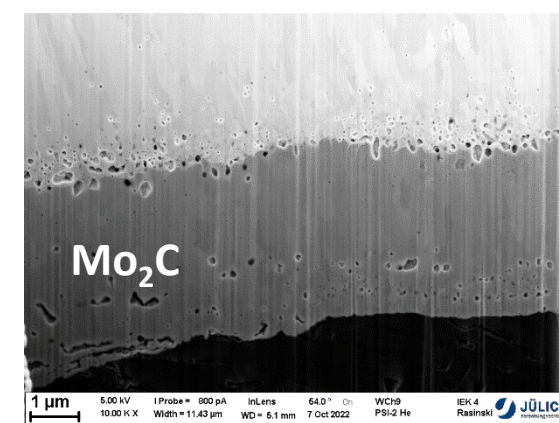
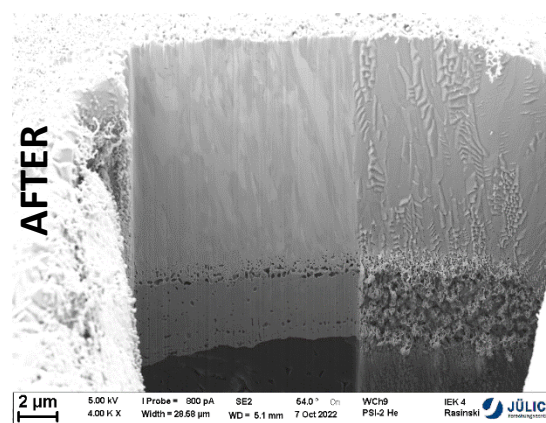
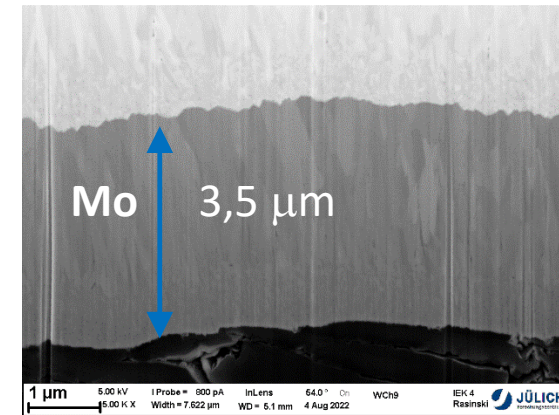
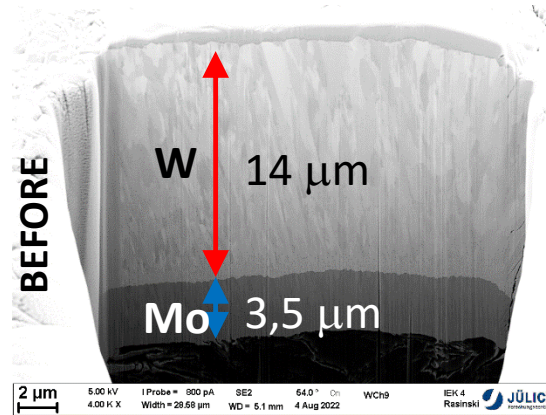
## W Ch 9

Exposure at 950 °C for 1h leads to formation of Mo<sub>2</sub>C at the interface

More on carbide formation due to annealing:

*M. Rasinski et al. / Thin Solid Films 2013 531  
doi.org/10.1016/j.tsf.2012.10.066*

*H Maier et al. / Phys. Scr. 2016 014048  
doi:10.1088/0031-8949/T167/1/014048*



# Samples for helium plasma studies on JET

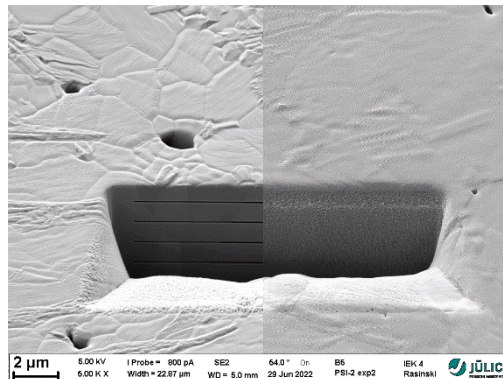


## 2<sup>nd</sup> exposure – He campaign

Temperature ~ 700 °C

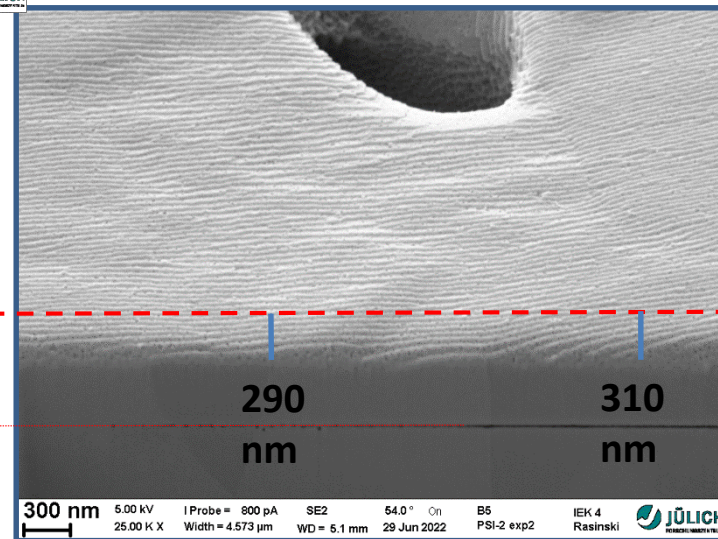
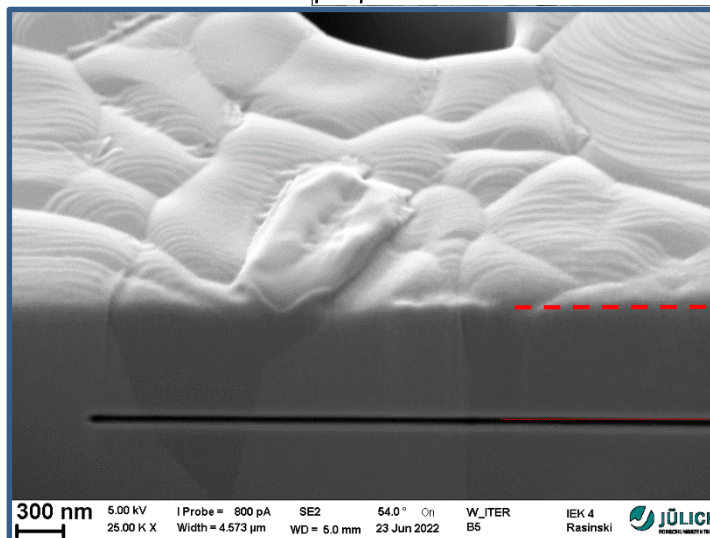
Ion Flux ~  $1.1\text{-}1.2 \times 10^{22} \text{ m}^{-2}\text{s}^{-1}$

Fluence ~  $2 \times 10^{26} \text{ m}^{-2}$



## Erosion – 300 nm

W\_ITER5



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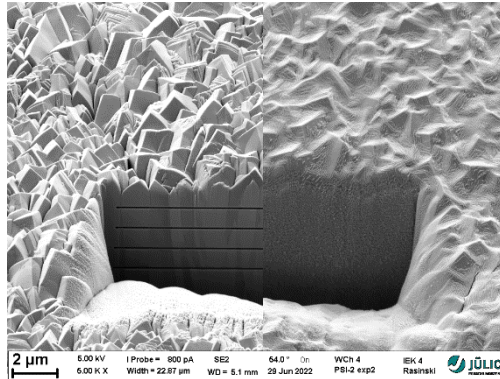


## 2<sup>nd</sup> exposure – He campaign

Temperature ~ 700 °C

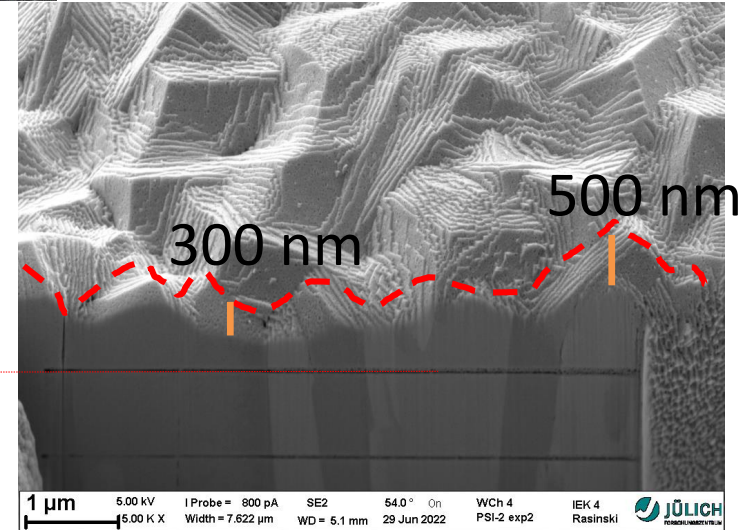
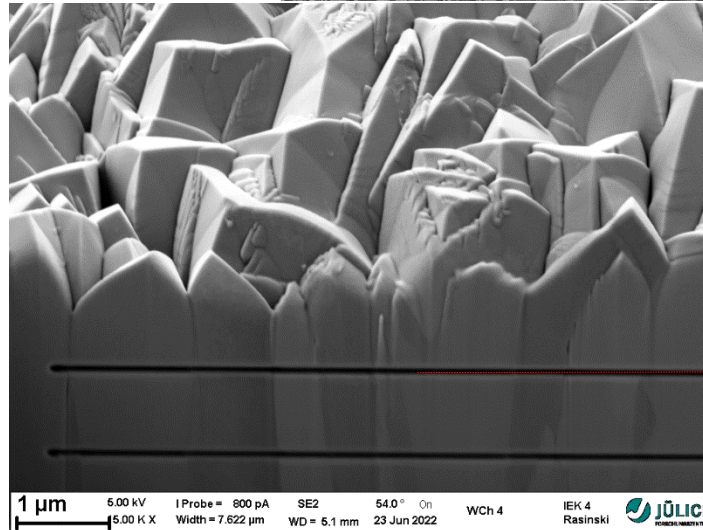
Ion Flux ~  $1.1-1.2 \times 10^{22} \text{ m}^{-2}\text{s}^{-1}$

Fluence ~  $2 \times 10^{26} \text{ m}^{-2}$



Erosion – 300 - 500 nm

W Ch4





# Exposure at $t_s \approx 700^\circ\text{C}$ - ELM simulation by laser



## fast IR measurements resolving laser pulses

### 3<sup>rd</sup> exposure: ELM-like heat pulse

Temperature  $\sim 730^\circ\text{C}$  (global)

$800^\circ\text{C}$  (laser pulse)

Ion Flux  $\sim 1.1\text{-}1.2 \times 10^{22} \text{ m}^{-2}\text{s}^{-1}$

Fluence  $\sim 2 \times 10^{26} \text{ m}^{-2}$

### WCh7 - ELM

Frequency: 30 Hz

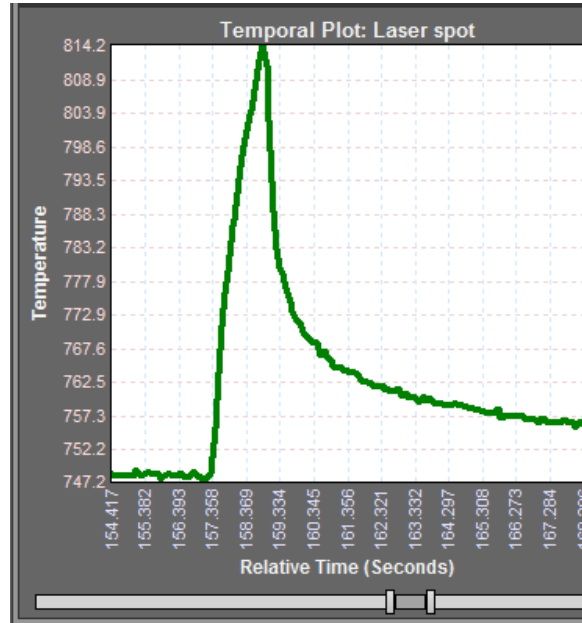
Pulse duration: 1 ms

Absorbed power density  $0.065 \text{ GW/m}^2$ .

Energy –  $1.623 \text{ J/pulse}$

Average power –  $48.69 \text{ W}$

- With reduced area of observation, it is possible to increase the camera frame rate to  $\approx 3600 \text{ fps}$ , thus resolving individual laser heat pulses



- Laser pulses increase the local surface temperature by  $60\text{-}70^\circ\text{C}$  to max of  $\approx 800^\circ\text{C}$ .

- For steady-state at  $\approx 800^\circ\text{C}$  W fuzz is normally formed. However, here no W fuzz was observed. Laser has probably too low duty cycle to allow for W fuzz formation.



# Samples for helium plasma studies on JET

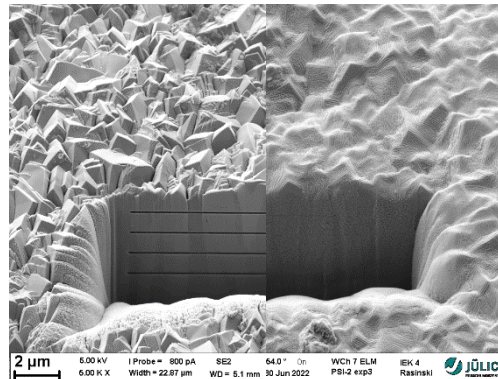


3<sup>rd</sup> exposure: ELM-like heat pulse

Temperature ~ 730 °C (global)

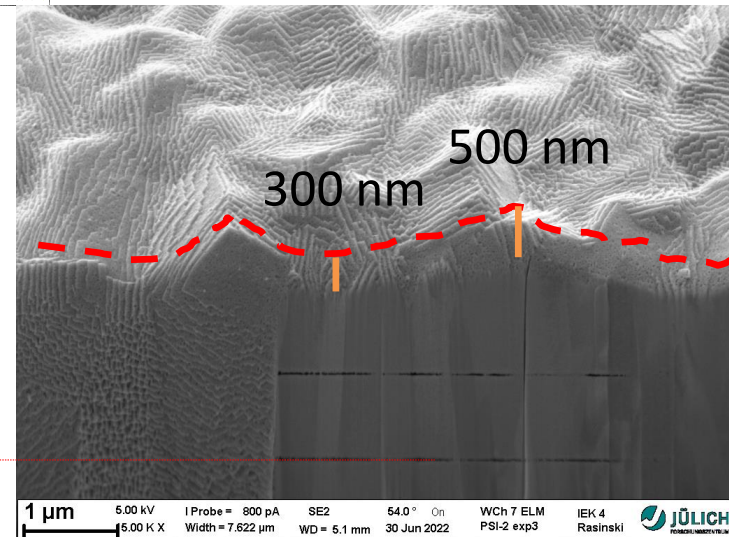
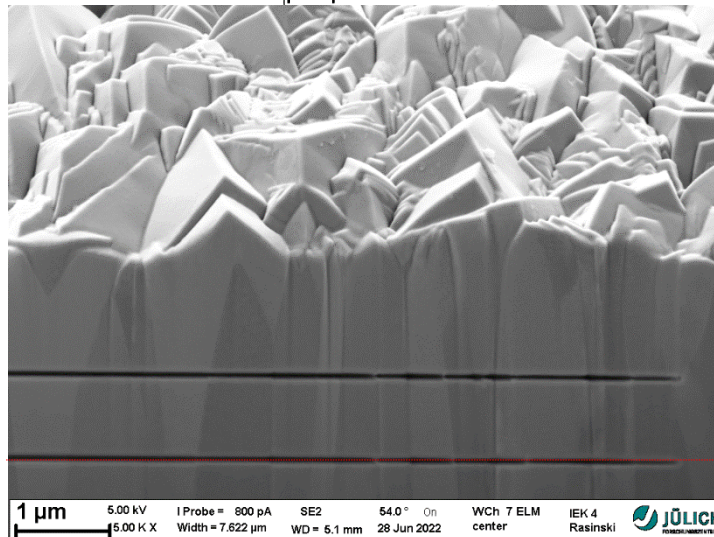
Ion Flux ~  $1.1-1.2 \times 10^{22} \text{ m}^{-2}\text{s}^{-1}$

Fluence ~  $2 \times 10^{26} \text{ m}^{-2}$



Erosion – 300 - 500 nm

WCh7 - ELM



# Conclusions



## 1<sup>st</sup> exposure – Fuzz formation

Temperature ~ 950 °C

Ion Flux ~  $4.5 \times 10^{21} \text{ m}^{-2}\text{s}^{-1}$

Fluence ~  $1.5 \times 10^{25} \text{ m}^{-2}$

## 2<sup>nd</sup> exposure – He campaign conditions 700 °C

Temperature ~ 700 °C

Ion Flux ~  $1.1\text{-}1.2 \times 10^{22} \text{ m}^{-2}\text{s}^{-1}$

Fluence ~  $2 \times 10^{26} \text{ m}^{-2}$

## 3<sup>rd</sup> exposure – He campaign conditions 700 °C + ELM-like heat pulse

Temperature ~ 730 °C

Ion Flux ~  $1.1\text{-}1.2 \times 10^{22} \text{ m}^{-2}\text{s}^{-1}$

Fluence ~  $2 \times 10^{26} \text{ m}^{-2}$

- ✓ Clear W-fuzz formation
- ✓ Fuzz growing in all directions
- ✓ Fuzz dimension ~ up to 1.5 μm

- ✓ NO W-fuzz formation
- ✓ Erosion ripple structure formation
- ✓ Nano-bubble formation
- ✓ Predominantly erosion
- ✓ Estimated erosion ~ 300-500 nm

- ✓ NO W-fuzz formation
- ✓ Erosion ripple structure formation
- ✓ Nano-bubble formation
- ✓ Predominantly erosion
- ✓ Estimated erosion ~ 300-500 nm
  
- ✓ Not a visible difference as compared with 2<sup>nd</sup> exposure (without laser interaction)

**JET bulk lamella, W-coatings and ITER grade W behaves very similar under given PSI-2 He exposures**



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**JET**



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# Samples for helium plasma studies on AUG



12 samples for AUG He campaign  
6 polished + 6 polished and fuzz

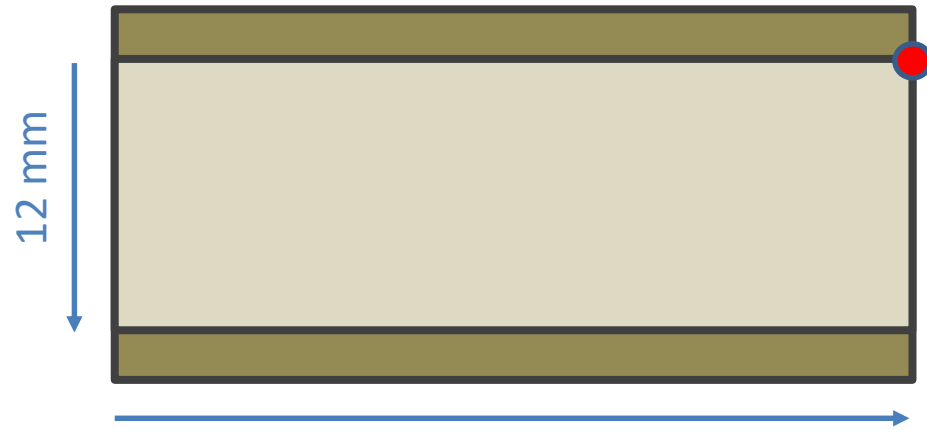
**PSI-2 exposure - Fuzz formation**

Temperature  $\sim 900\text{ }^{\circ}\text{C}$

Ion Flux  $\sim 8.4 \times 10^{21}\text{ m}^{-2}\text{s}^{-1}$

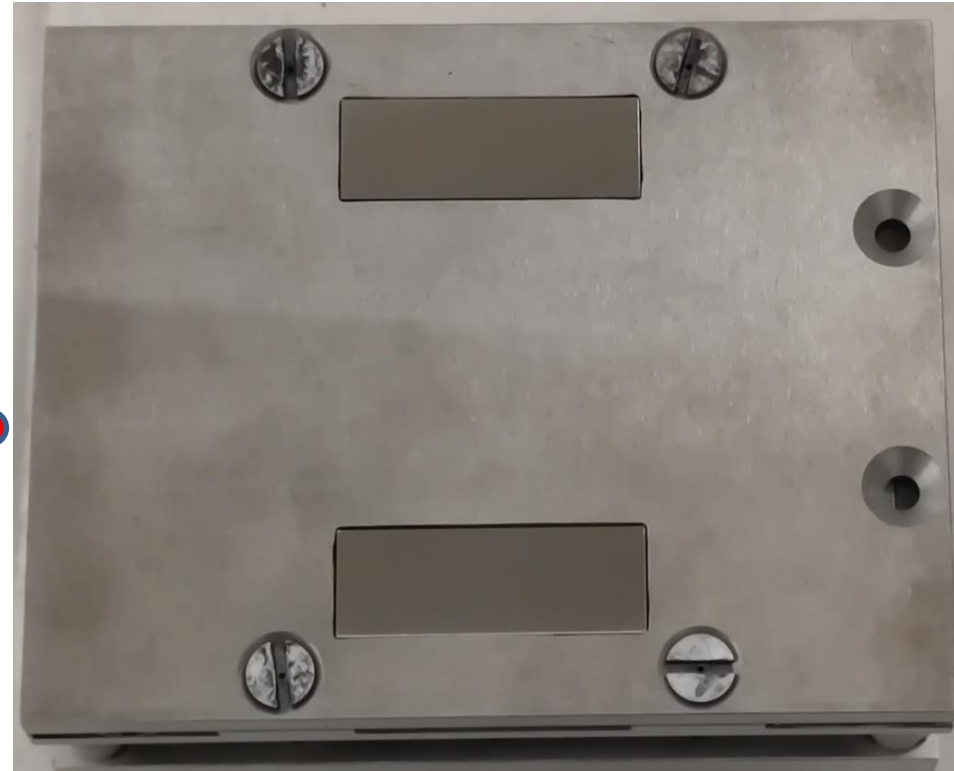
Fluence  $\sim 1.5 \times 10^{25}\text{ m}^{-2}$

Energy  $\sim 80\text{ eV}$



Sample geometry

35 mm



PSI-2 sample holder with 2 samples mounted before He plasma exposure



# Samples for helium plasma studies on AUG



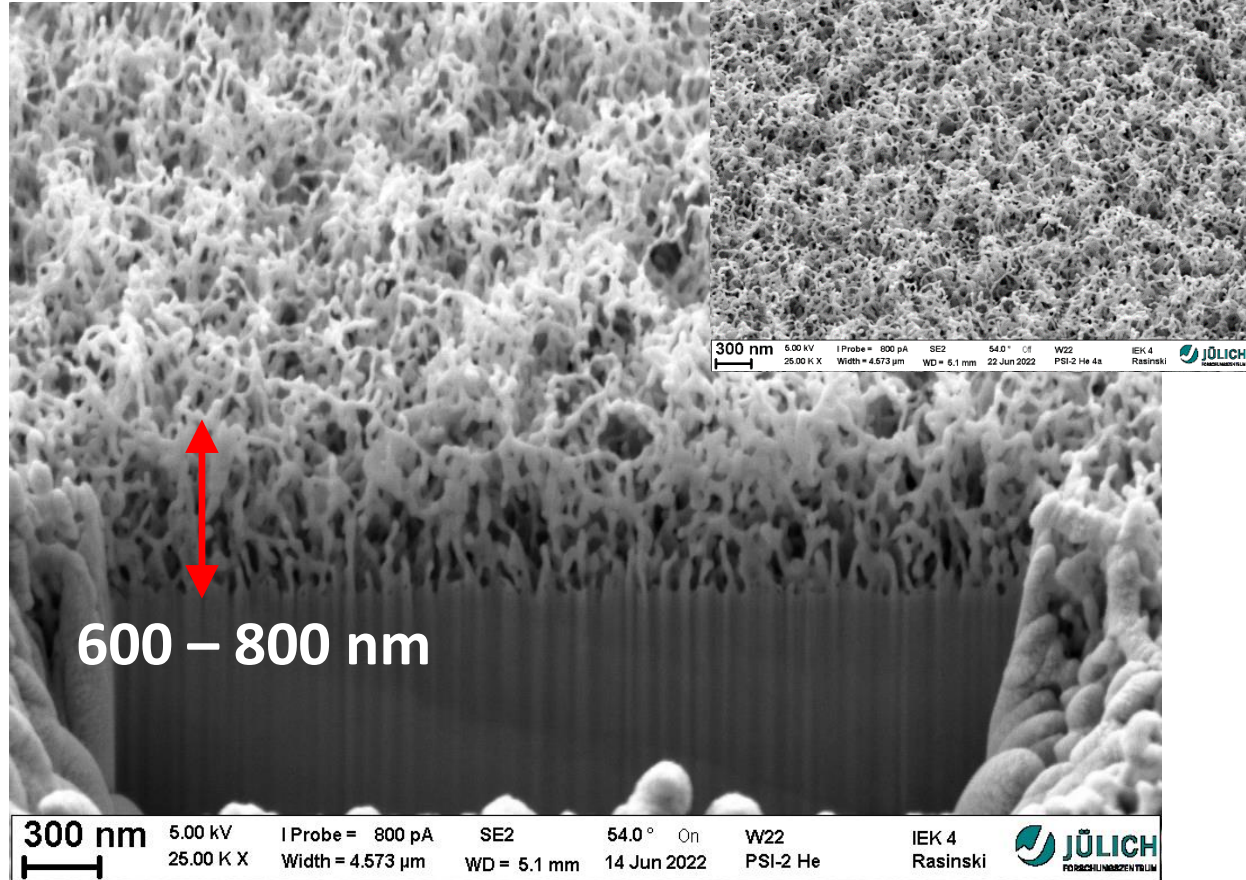
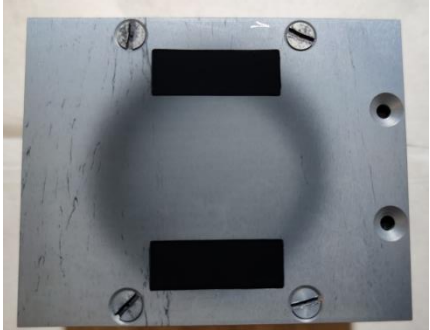
## PSI-2 exposure - Fuzz formation

Temperature  $\sim 900\text{ }^{\circ}\text{C}$

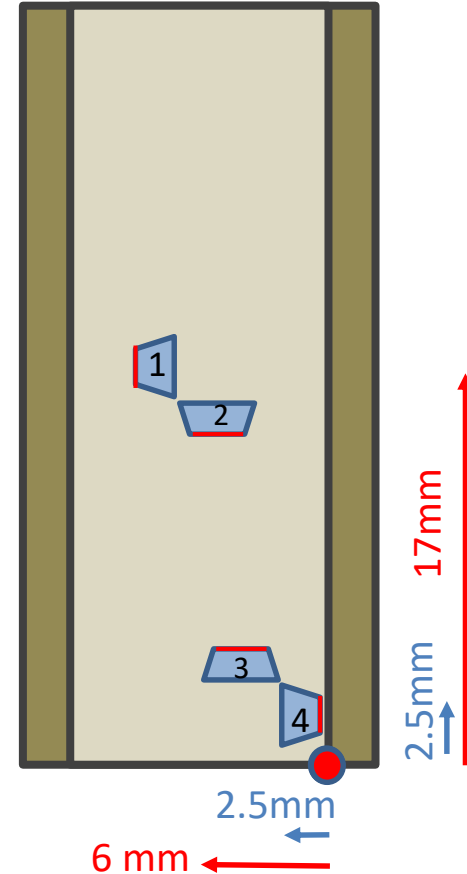
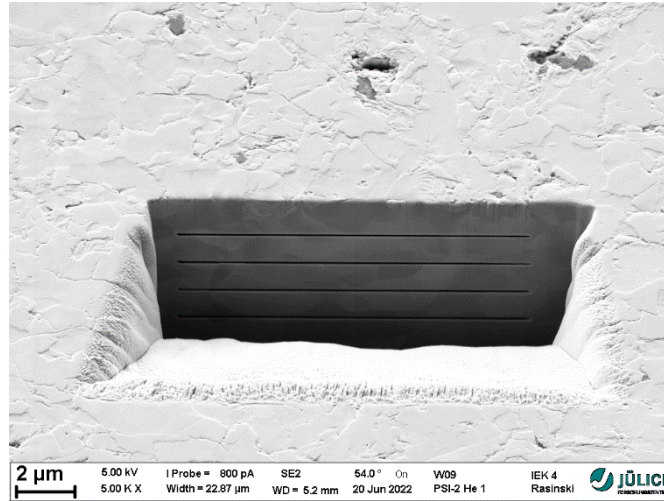
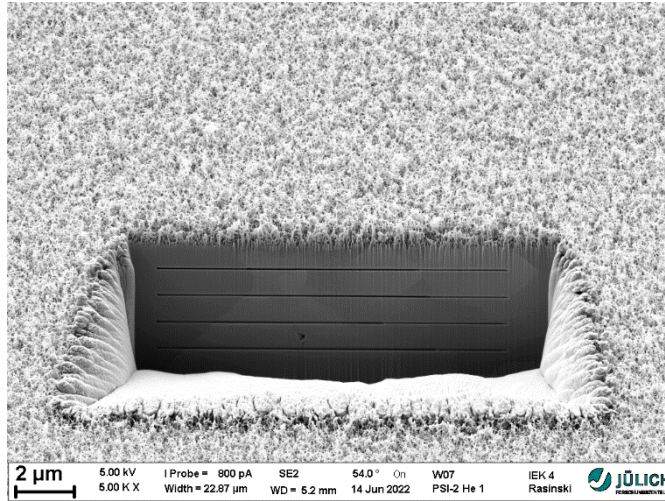
Ion Flux  $\sim 8.4 \times 10^{21}\text{ m}^{-2}\text{s}^{-1}$

Fluence  $\sim 1.5 \times 10^{25}\text{ m}^{-2}$

Energy  $\sim 80\text{ eV}$



# Samples for helium plasma studies on AUG

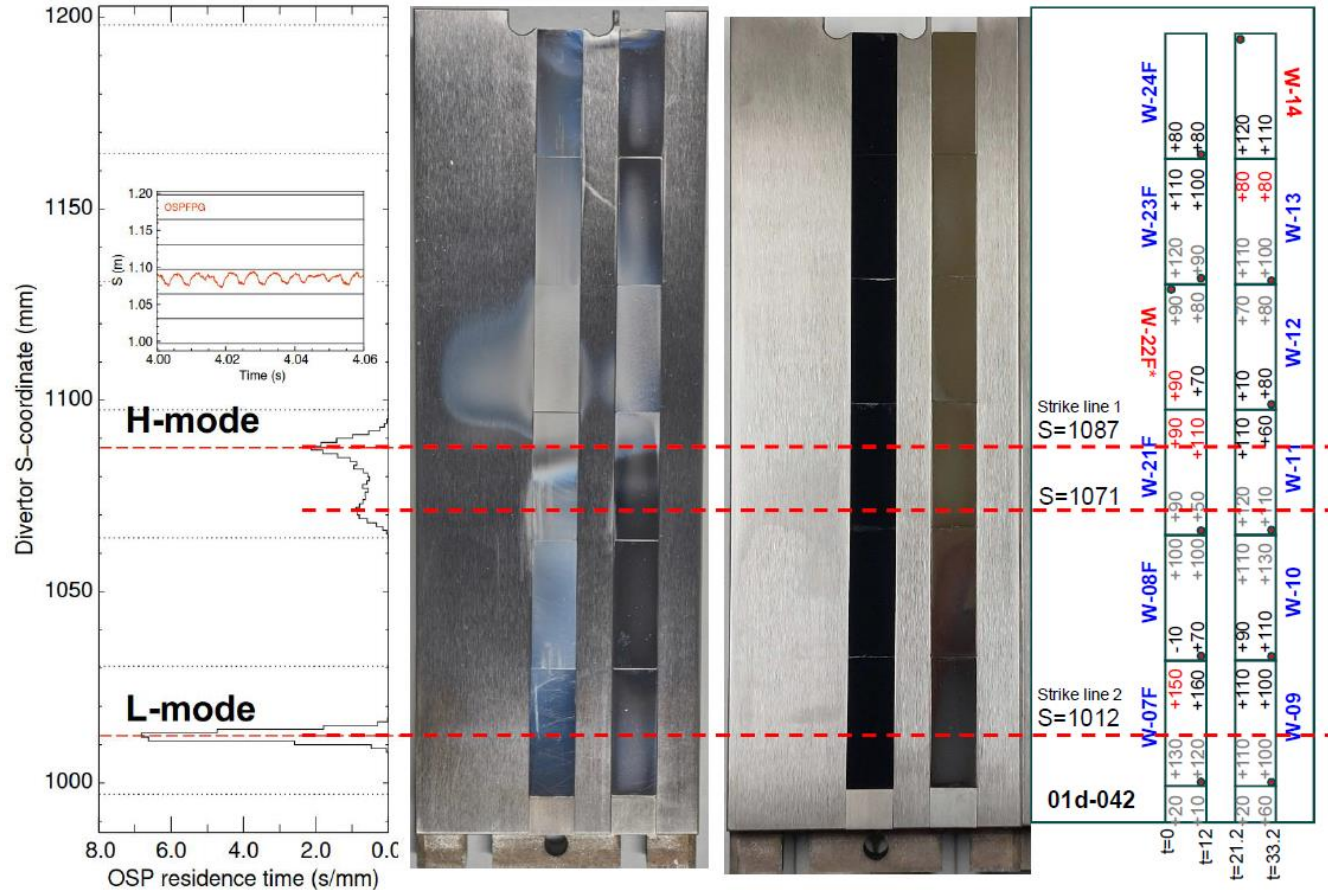


- On each sample **4 FIB cross-sections** with line marking
- **Different position and orientation** of each cross-section for better understanding the influence of plasma direction
- Cross-section examined **after AUG He** campaign to determine the erosion/deposition and fuzz formation

# Samples for helium plasma studies on AUG



- 8 ok H-mode
- 6 ok L-mode

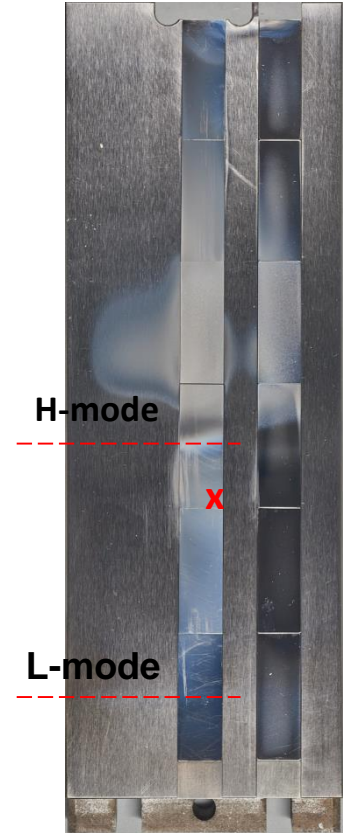
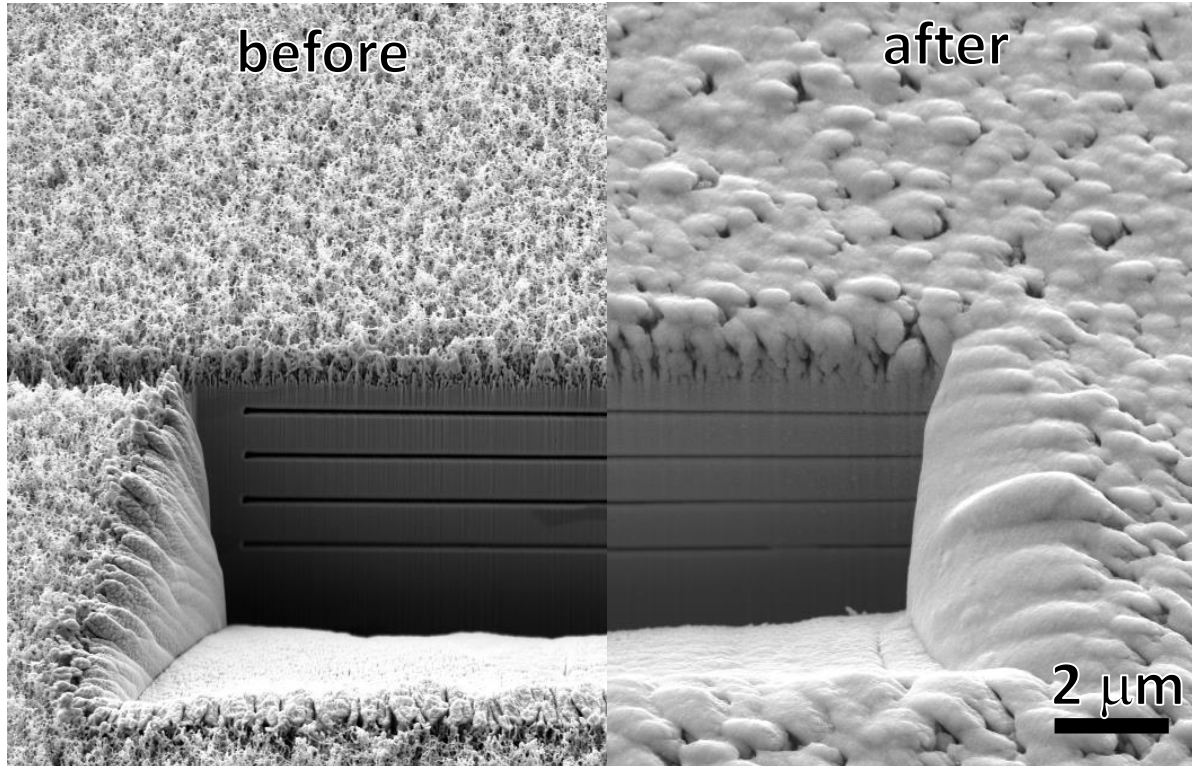




# Samples for helium plasma studies on AUG



Sample W21 fuzz  
cross-section 3

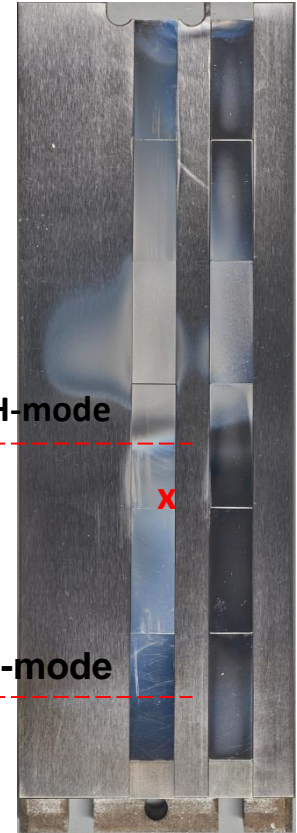
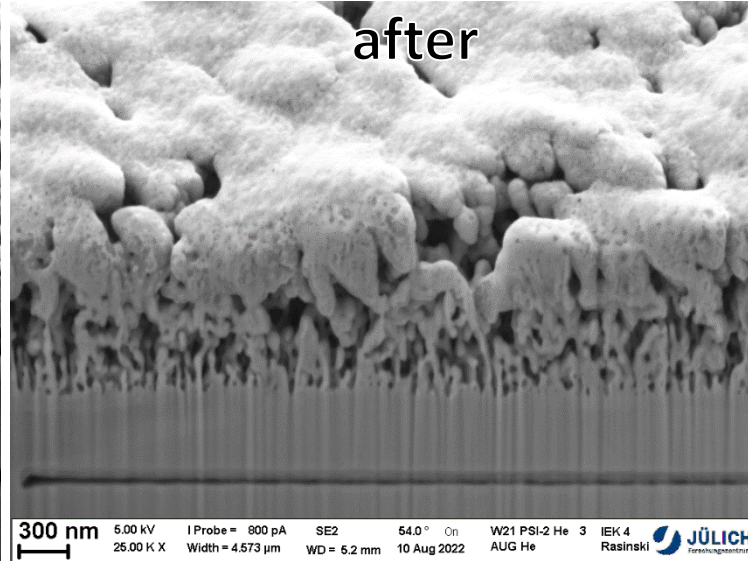
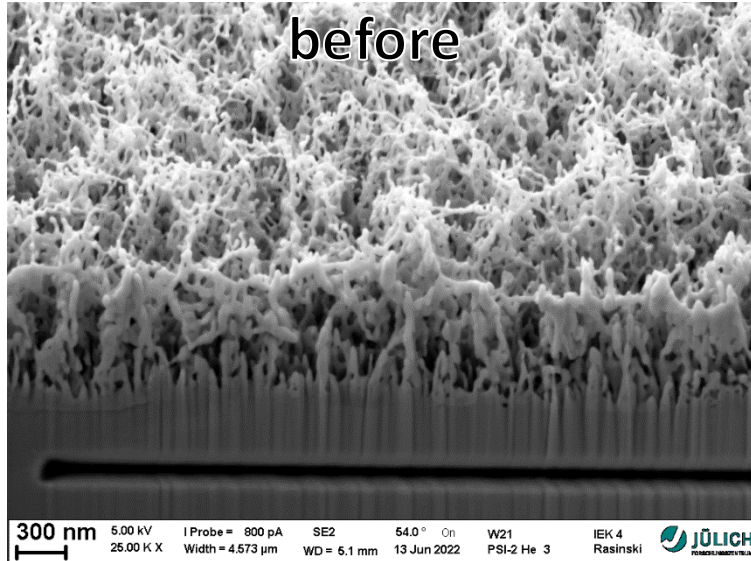




# Samples for helium plasma studies on AUG



Sample W21 fuzz  
cross-section 3

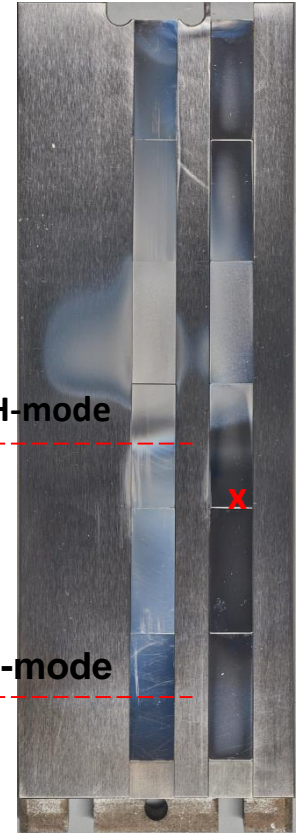
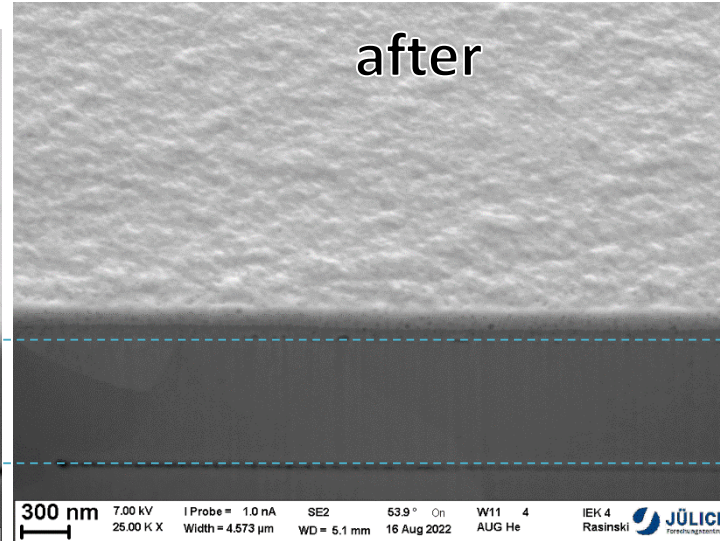
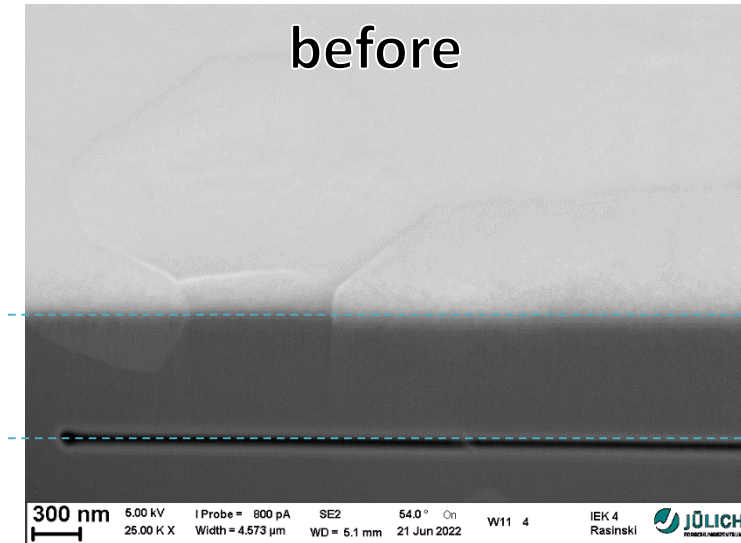


Fuzz structure from PSI-2 preserved  
On top deposited layer of about 200 nm

# Samples for helium plasma studies on AUG



Sample W11 polished  
cross-section 3



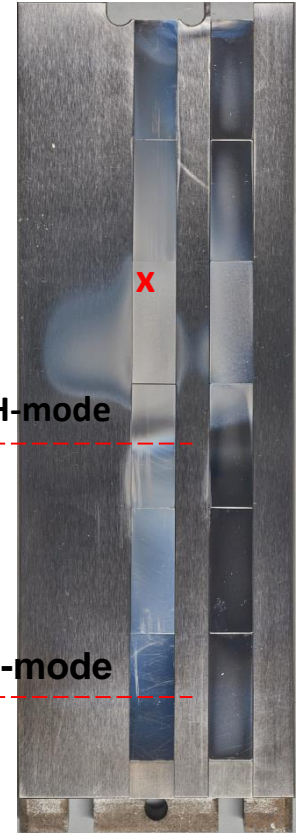
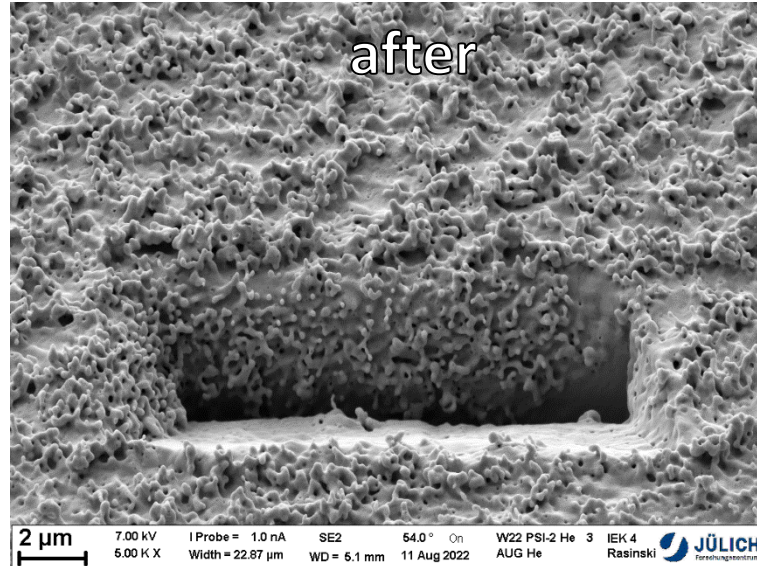
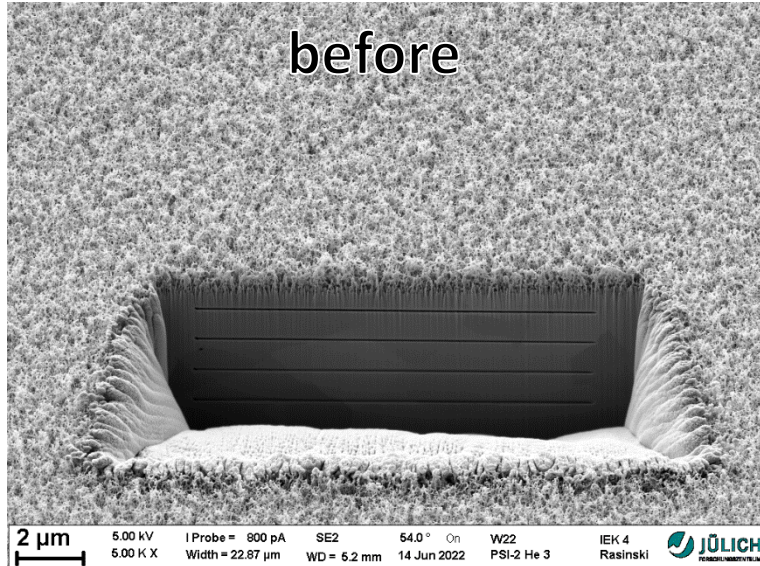
Deposited layer of about 200 nm  
Deposition very similar to those on a fuzzy sample



# Samples for helium plasma studies on AUG

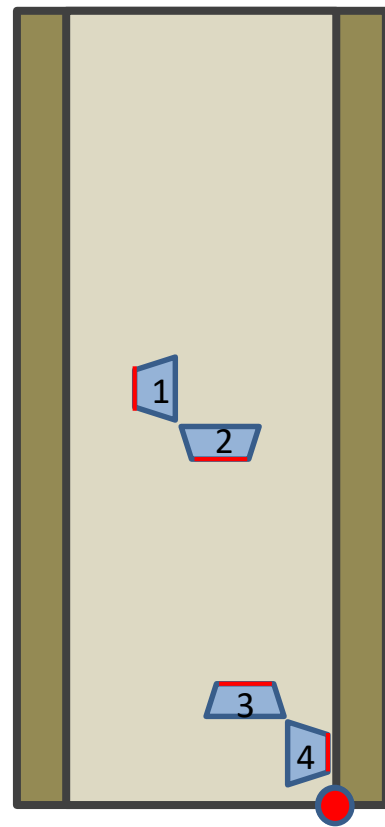
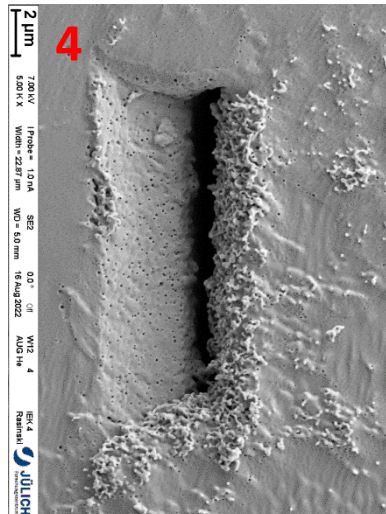
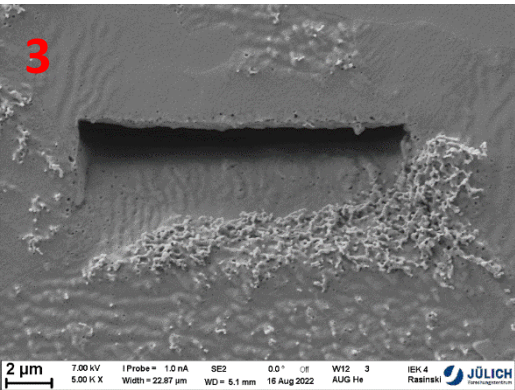
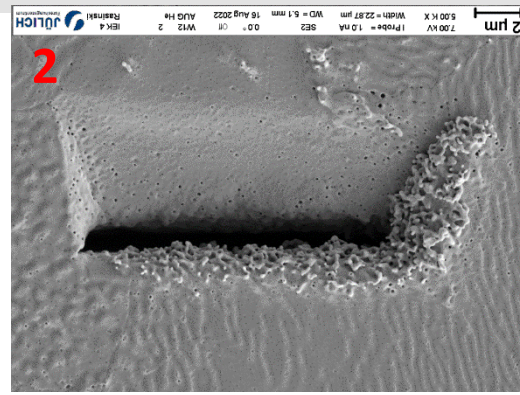
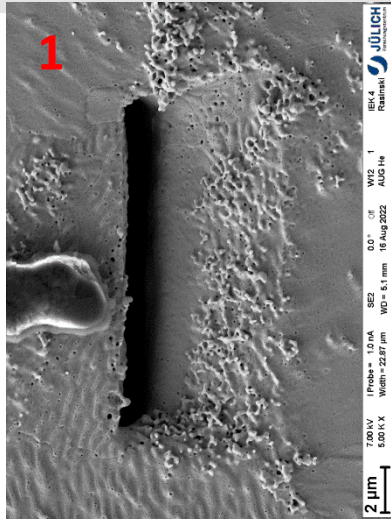


Sample W22 fuzz  
cross-section 3



Fuzz formed in PSI-2 removed/modified  
New fuzz observed

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Sample W12 polished

